Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/519,998	KAMBARA ET AL.	
Examiner	Art Unit	
John S. Chu	1752	

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Class	Subclass	Date	Examiner
430	270.1	3/2017	Jec.
430	905	1	
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Class	Subclass	Date	Examiner		

3/2007	NEC
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